VE320 – Summer 2021

Introduction to Semiconductor Devices

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Chapter 12 Bipolar Junction Transistor

Outline

- 12.1 Review and example
- 12.2 Bipolar Junction transistor
- 12.3 Early Effect
- 12.4 Summary
- 12.5 Quantitative analysis of BJT gain

Outline

12.1 Review and example

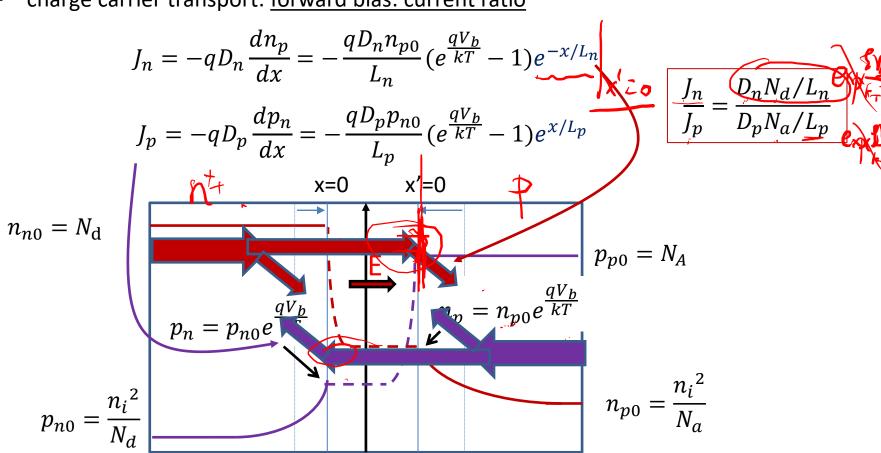
12.2 Bipolar Junction transistor

12.3 Early Effect

12.4 Summary

12.1 Previously: pn Junction Current

charge carrier transport: <u>forward bias: current ratio</u>



Assumption: No recombination-generation in depletion region.





12.1 Example: pn Junction Current

Finding L_n , τ_n in **p-type** region because electrons are minority carriers.

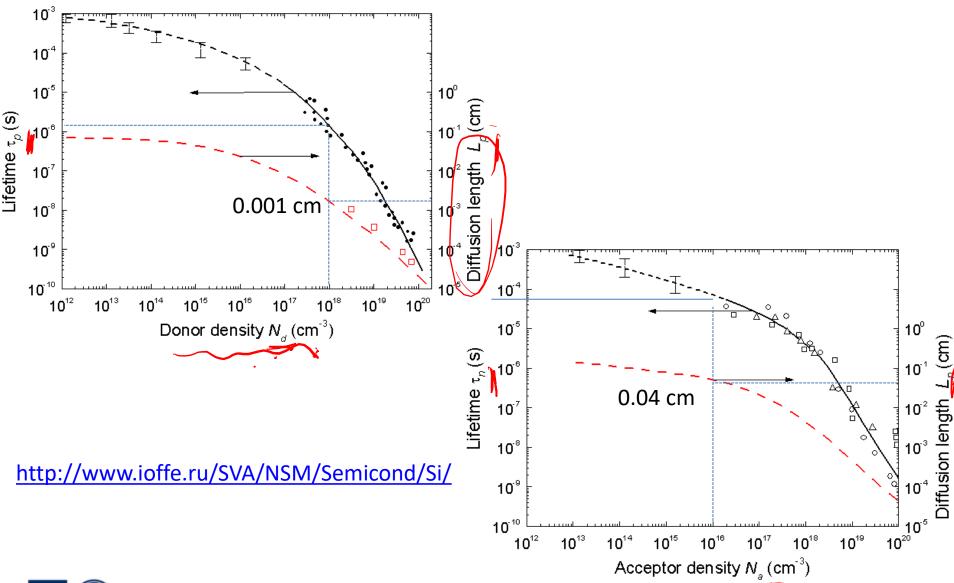
For
$$N_a = 10^{16} \text{ cm}^{-3}$$
 $L_n = 0.04 \text{cm}$ $\tau_n = 5 \times 10^{-5} \text{ s}$

Finding L_p , τ_p in **n-type** region because holes are minority carriers.

For
$$N_d = 10^{18} \text{ cm}^{-3}$$
 $L_p = 0.0015 \text{ cm}$ $\tau_p = 1.5 \times 10^{-6} \text{ s}$

$$\frac{J_n}{J_p} = \frac{D_n N_d / L_n}{D_p N_a / L_p} = \frac{L_n / \tau_p}{L_p / \tau_p} \frac{N_d}{N_a} \approx \frac{\frac{4 \times 10^{-2}}{5 \times 10^{-5}}}{\frac{1.5 \times 10^{-3}}{1.5 \times 10^{-6}}} \times \frac{10^{18}}{10^{16}} = 80$$

12.1 Example: pn Junction Current



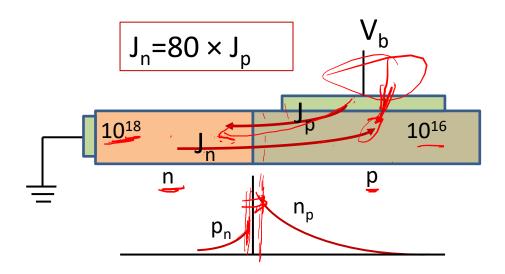
Outline

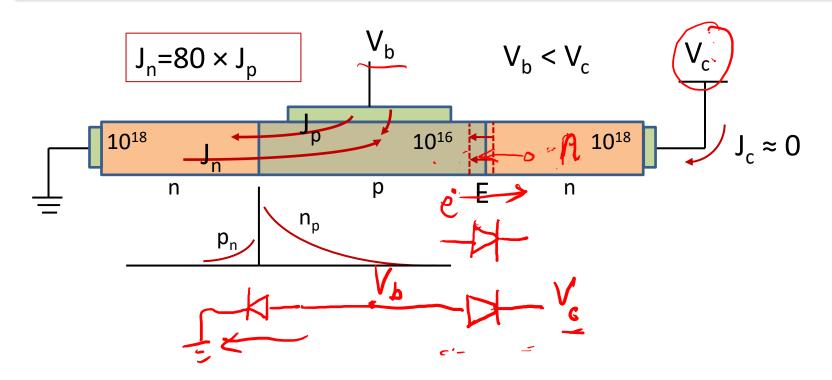
12.1 Review and example

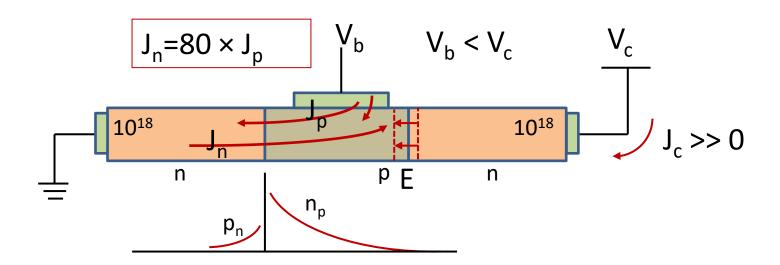
12.2 Bipolar Junction transistor

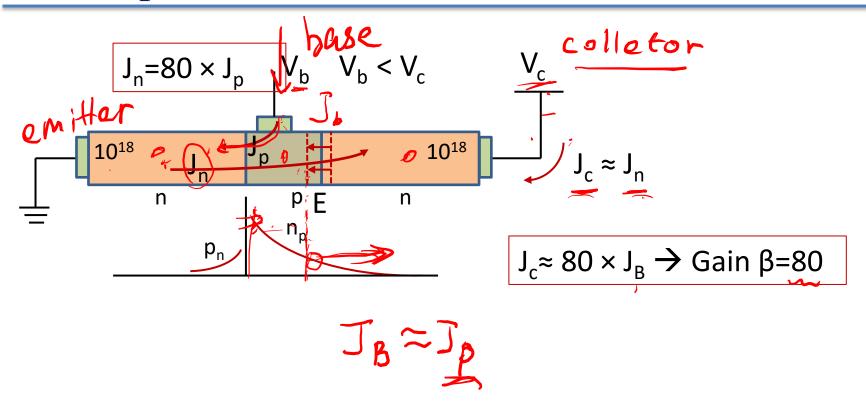
12.3 Early Effect

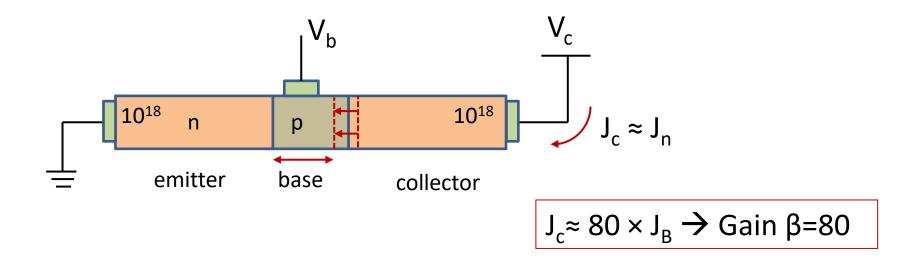
12.4 Summary





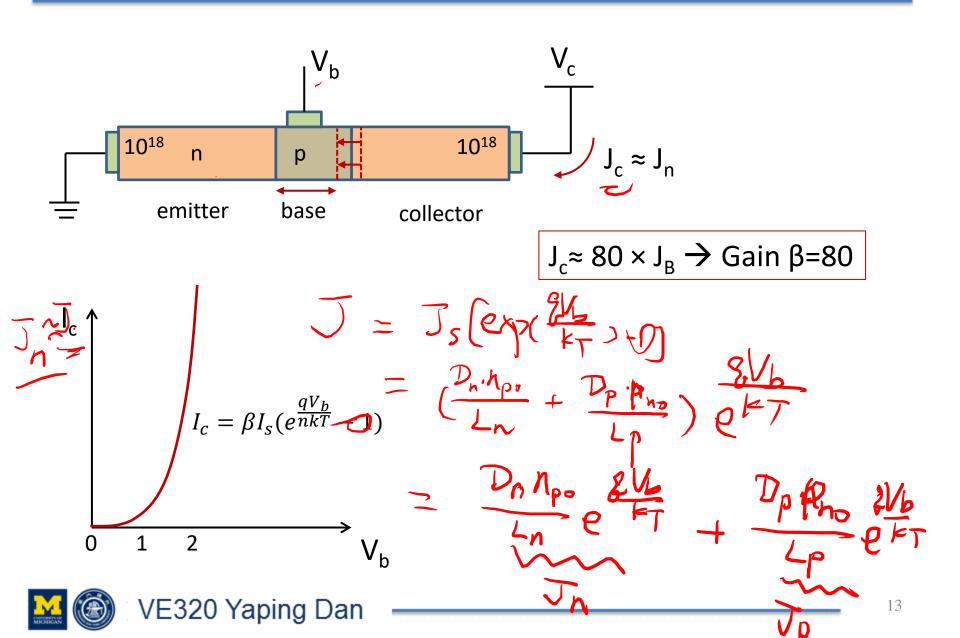


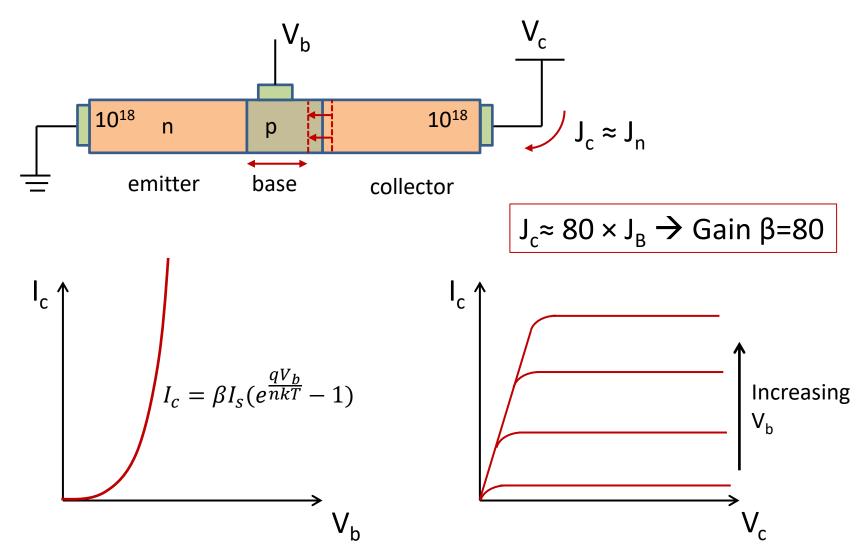


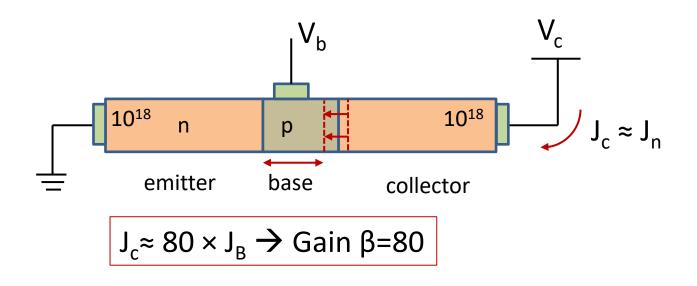


BJT Charateristics:

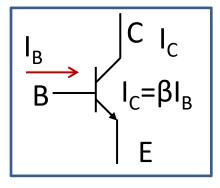
- Base width smaller
 higher gain
- 2. Larger emitter-base concentration ratio \rightarrow higher gain

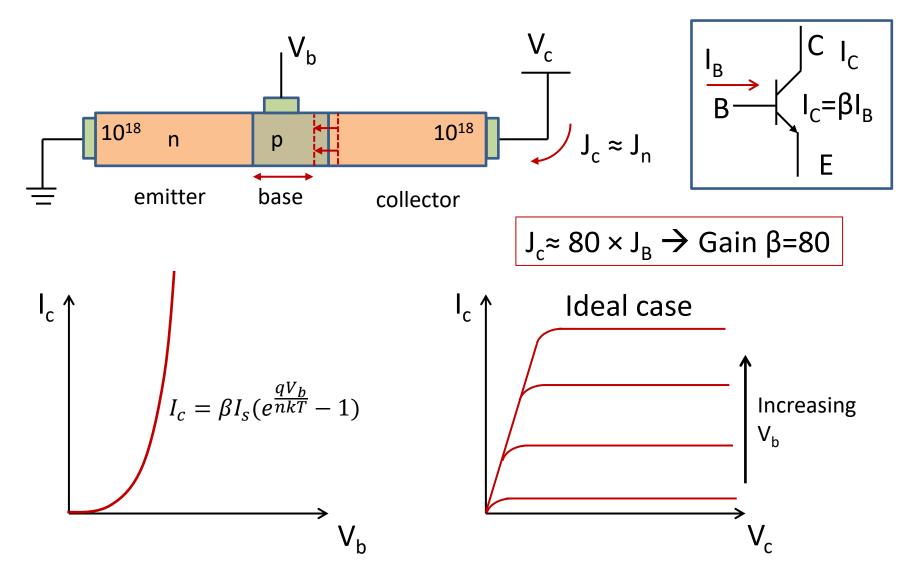






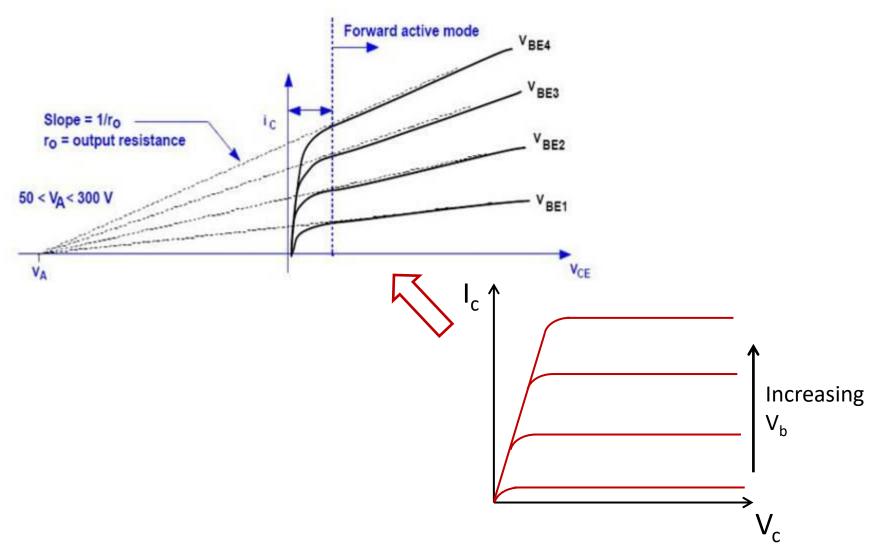
Basic facts:

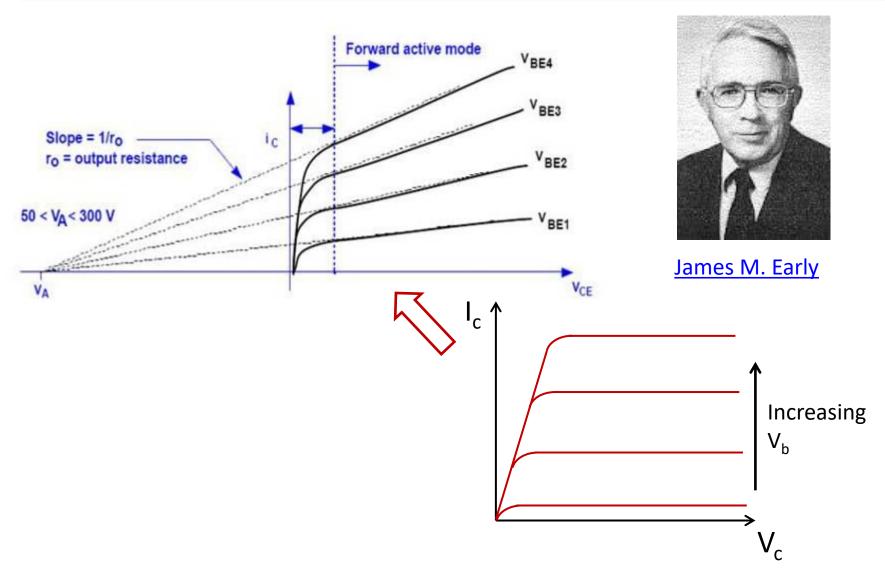


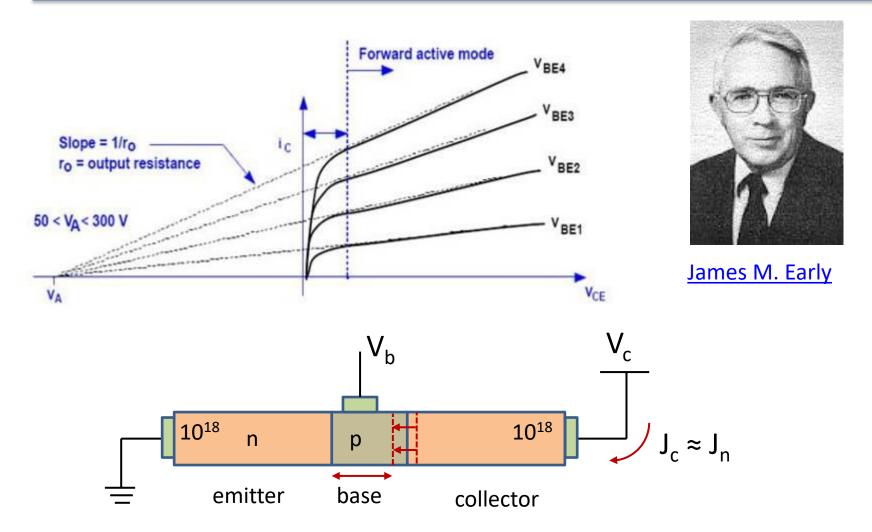


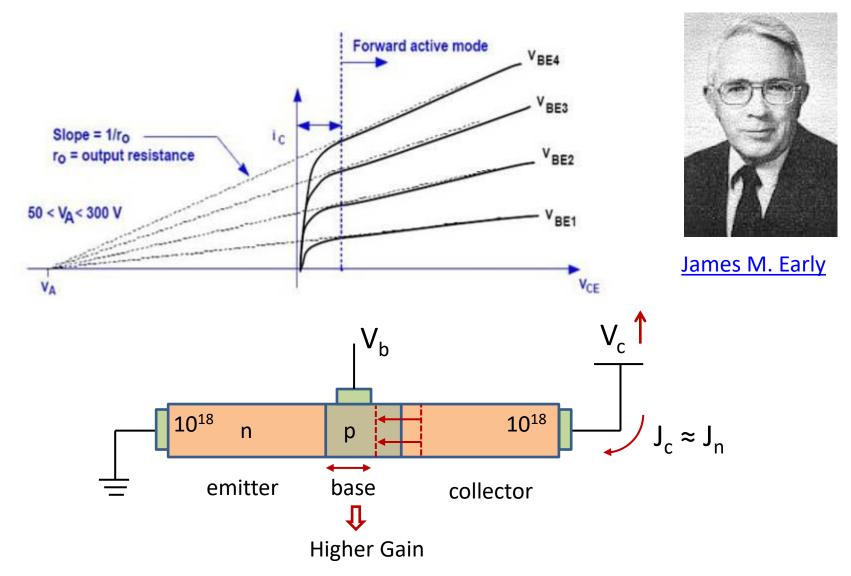
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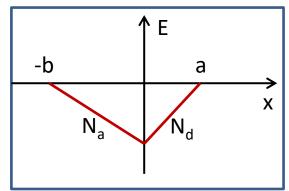


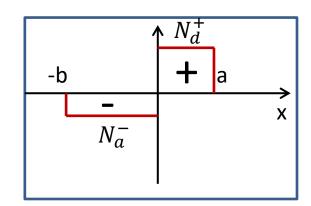


Previously...

$$a = \sqrt{\frac{2\varepsilon(V_{bi} - V_R)}{q} \frac{N_a}{N_d} \frac{1}{N_a + N_d}}$$

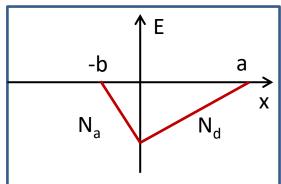
$$N_A^- b = N_D^+ a \Rightarrow b = \sqrt{\frac{2\varepsilon(V_{bi} - V_R)}{q} \frac{N_d}{N_a} \frac{1}{N_a + N_d}}$$

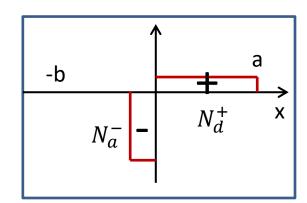




Previously...

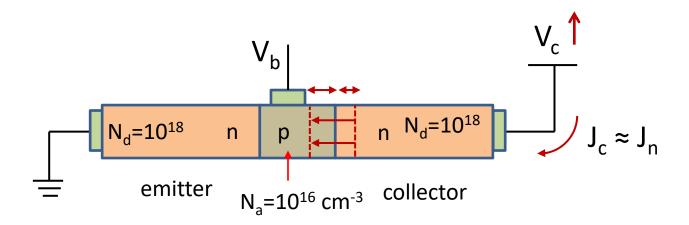
Depletion region width W = a + b





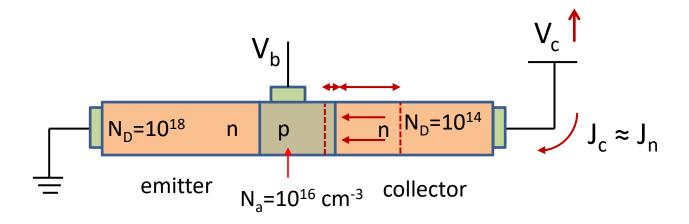


James M. Early





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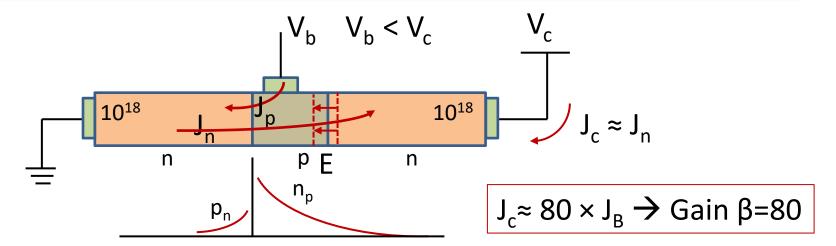


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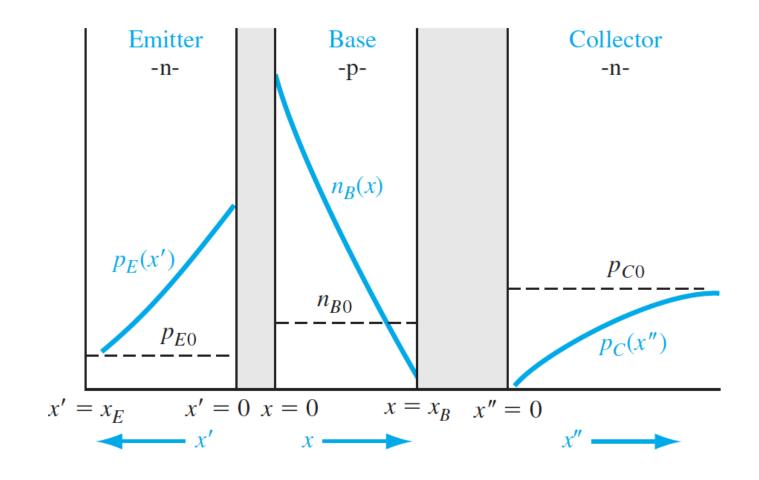


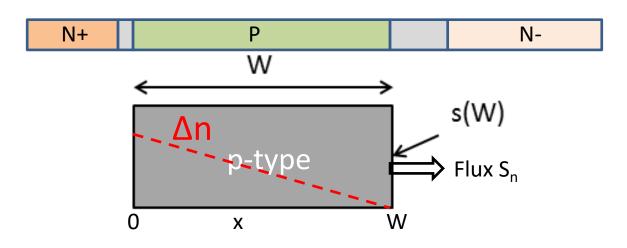
- 1. highest doping concentration is limited by solubility (<10²⁰)
- 2. Lowest doping concentration is limited by n_i and fabrication process

Basic facts:

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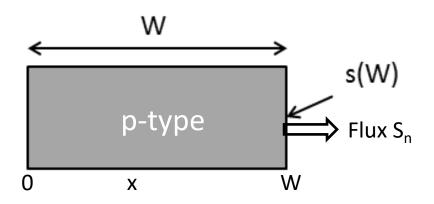




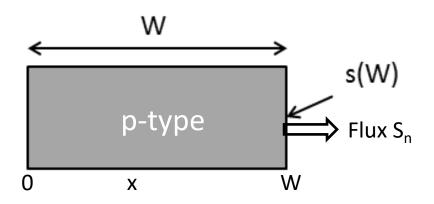
$$N_a = 10^{17}$$
 cm⁻³, $D_n = 10$ cm²/s, $\tau_n = 10^{-7}$ s, SRV s(x=W)= ∞ Δn (x=0) = 10^{14} cm⁻³

Find the electron flux Sn at x=0 and W, if

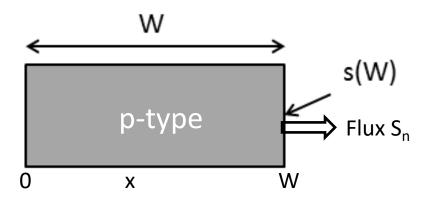
- 1) W=20um
- 2) W=2um



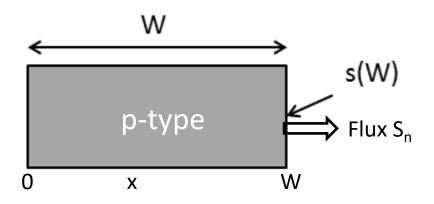
$$0 = D_n \frac{\partial^2 \Delta n}{\partial x^2} - \frac{\Delta n}{\tau}$$



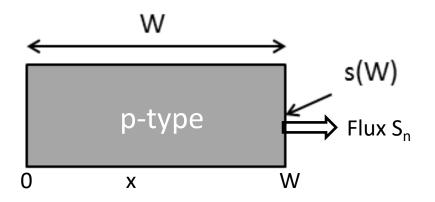
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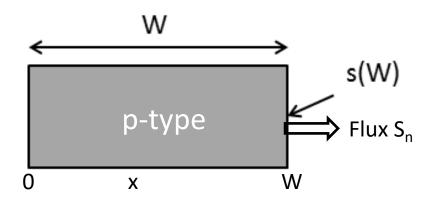
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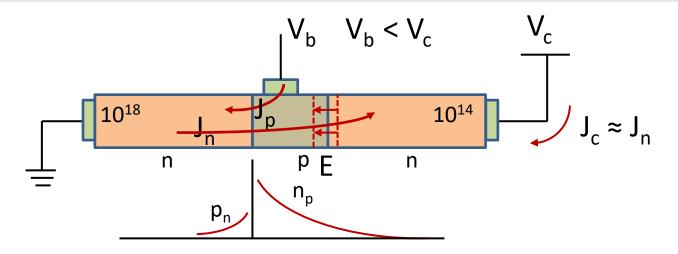


$$0 = D_n \frac{\partial^2 \Delta n}{\partial x^2} - \frac{\Delta n}{\tau}$$



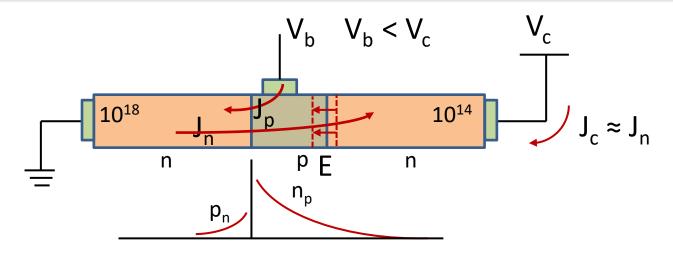
$$0 = D_n \frac{\partial^2 \Delta n}{\partial x^2} - \frac{\Delta n}{\tau}$$





Electron flux from emitter to base: $S_n(0)$

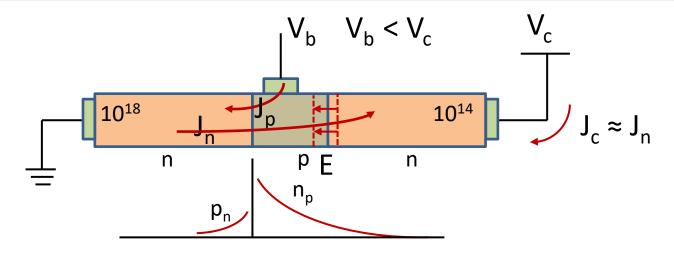
Electron flux from base to collector: $S_n(W_b)$



Electron flux from emitter to base: $S_n(0)$

Electron flux from base to collector: $S_n(W_b)$

Hole flux from base to emitter: S_p

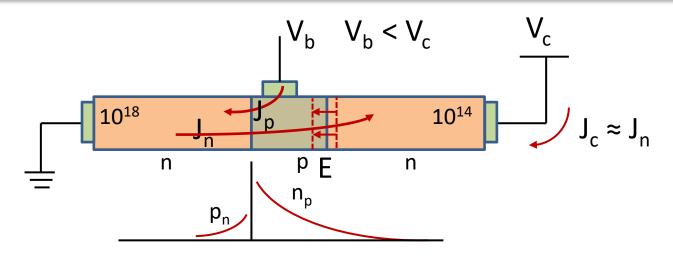


Electron flux from emitter to base: $S_n(0)$

Electron flux from base to collector: S_n(W_b)

Hole flux from base to emitter: S_p

Base electrode flux: $S_p + S_n(0)-S_n(W_b)$



Electron flux from emitter to base: $S_n(0)$

Electron flux from base to collector: $S_n(W_b)$

Hole flux from base to emitter: S_p

Base electrode flux: $S_p + S_n(0)-S_n(W_b)$

Gain β = collector flux /base electrode flux = $S_n(W_b)/(S_p + S_n(0) - S_n(W_b))$





